



# PRODUCT SPECIFICATION

## PRODUCT SPECIFICATION FOR INTERNAL SHIELDED JACKS

### 1.0 SCOPE

This specification covers the Molex internal shielded product line which comprises a shielded plug (male) and a jack (female) I/O type connector.

This system contains an internal shield to provide enhanced ESD protection. Where applicable, tests are in accordance with, or in excess of IEC 60603-7.

### 2.0 PRODUCT DESCRIPTION

SMT R/A Shielded jack with side solder tabs.

95540-\*\*\*\*

SMT R/A Shielded jack with thru-hole solder pegs.

95540-\*\*\*\*

### 2.1 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

See the appropriate sales drawings for information on dimensions, materials, plating and markings.

CONTACT FINISH: GOLD

Post Plate 0.00127-0.00152mm Gold in contact area.

0.00190mm Min pure Tin in Tail area, both over 0.00127mm Min Nickel overall.

**OR,**

PALLADIUM NICKEL WITH GOLD FLASH:

Post plate 0.00005mm Min Gold Flash over 0.00060mm Min Palladium Nickel in contact area,

0.00190mm Min pure Tin in tail area, both over 0.00127mm Min Nickel overall.

### 3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

See the appropriate Sales Drawings and the other sections of this specification for the necessary Referenced Documents and specifications.

IEC-60603-7

TIA-1096-A

### 4.0 RATINGS

#### 4.1 VOLTAGE

125 Volts d.c.

#### 4.2 CURRENT

1.5 Amps

#### 4.3 TEMPERATURE

Operating: - 40°C to + 85°C

Non-operating: - 40°C to + 85°C

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## 5.0 TEST SCHEDULES

The following tests specify the characteristics to be checked and the requirements to be fulfilled.

For a complete test sequence, 62 specimens are needed. This equals 6 groups of 10 and 1 group of 2, the group of 2 shall be for Group EP.

All specimens shall be subjected to the following tests. All the test group specimens shall be subjected to the preliminary group P tests in the following sequence.

The specimens shall then be divided into the appropriate number of groups. All connectors in each group shall undergo the following tests as described in the sequence given.

### Test group P

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
P 1	GENERAL EXAMINATION PER IEC 60512-1-1, Test 1a	Visual examination	There shall be no defects that would impair normal operation
P 2	N/a		
P 3	CONTACT RESISTANCE IEC 60512-2-1, Test 2a	Mated connectors:  (Measurement points per section 7.0)	Initial 20 mΩ maximum
P 4	INSULATION RESISTANCE IEC 60512-3-1, Test 3a, Method a.	Test voltage 100 V d.c. mated connectors	500 MΩ Minimum
P 5	VOLTAGE PROOF IEC 60512-4-1, Test 4a, Method a.	Contact/contact Method A Mated Connectors	1000 V d.c. or a.c. peak
		All contacts to panel: Method A Mated Connectors	1500 V d.c or a.c. peak

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## Test group AP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
AP 1	INSERTION AND WITHDRAWAL FORCES PER IEC 60512-13-2, Test 13b	Connector locking device depressed.	Insertion force 30 N max, Withdrawal force 30 N max.
AP 2	EFFECTIVENESS OF CONNECTOR COUPLING DEVICE  PER IEC 60512-15-6 Test 15f	Rate of load application 44.5 N/s maximum	50 N FOR 60s ± 5s
AP 3	RAPID CHANGE OF TEMPERATURE  PER IEC 60512-11-4	-40°C to 70°C Mated connectors 25 cycles t = 30 min recovery time 2 h	
AP 4	INSULATION RESISTANCE  IEC 60512-3-1, Test 3a, Method a.	Test voltage 100 V ± 15 V d.c. Method A MATED CONNECTORS	PER P4
AP 5	CONTACT RESISTANCE  IEC 60512-2-1, Test 2a	PER P3	20 mΩ maximum change from initial
AP 6	VOLTAGE PROOF  IEC 60512-4-1, Test 4a, Method a.	PER P5	PER P5
AP 7	VISUAL EXAMINATION	PER P1	PER P1
AP 8	CYCLIC DAMP HEAT  PER IEC 60068-2-38	21 cycles low temperature 25°C high temperature 65°C cold sub-cycle -10°C humidity 93 % Half of the samples in mated state Half of the samples in unmated state	
AP 9	CONTACT RESISTANCE  IEC 60512-2-1, Test 2a	PER P3	20 mΩ maximum change from initial

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# PRODUCT SPECIFICATION

Test group AP(continued).

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
AP 10	INSERTION AND WITHDRAWAL FORCES PER IEC 60512-13-2, Test 13b	PER AP1	PER AP1
AP 11	EFFECTIVENESS OF CONNECTOR COUPLING DEVICE PER IEC 60512-15-6 Test 15f	Rate of load application 44.5 N/s maximum	50 N FOR 60s ± 5s
AP 12	VISUAL EXAMINATION	PER P1	PER P1
AP 13	SOLDERABILITY	Solder Bath 260+0/-5°C Immersion Time 2,0 +/- 0.5s	The Dipped surface shall be covered with a smooth and bright solder coating. Some imperfections are acceptable but NOT concentrated in the same area.
AP 14	RESISTANCE TO SOLDERING HEAT	For recommended Reflow Profile (See Section 6.0)	Appearance: No damage.
AP 15	VOLTAGE PROOF IEC 60512-4-1, Test 4a, Method a.	PER P5	PER P5

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# PRODUCT SPECIFICATION

Test group BP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
BP 1	LOCKING DEVICE MECHANICAL OPERATIONS	5,000 operations	After the specified number of operations, the specimens shall show no visual indication of fatigue or stress cracking of the locking device.
BP 2	MECHANICAL OPERATIONS  PER IEC 60512-9-1, Test 9a	Mate connectors 1,250 cycles, at a maximum rate of 10mm/s maximum. Rest 1s (when mated and when unmated) Locking device inoperative.	
BP 3	FLOWING MIXED GAS CORROSION  PER IEC 60512-11-7, Test 11g	Method 1, 4 days Half of the samples in mated state Half of the samples in unmated state	
BP 4	CONTACT RESISTANCE  IEC 60512-2-1, Test 2a	PER P3	20 mΩ maximum change from initial
BP 5	MECHANICAL OPERATIONS  PER IEC 60512-9-1, Test 9a	Mate connectors 1,250 cycles, at a maximum rate of 10mm/s maximum. Rest 5s (when unmated) locking device inoperative.	
BP 6	CONTACT RESISTANCE  IEC 60512-2-1, Test 2a	PER P3	20 mΩ maximum change from initial
BP 7	INSULATION RESISTANCE  IEC 60512-3-1, Test 3a, Method a.	100V ± 15V d.c. Method a Mated connectors	PER P4
BP 8	VOLTAGE PROOF  IEC 60512-4-1, Test 4a, Method a.	PER P5	PER P5
BP 9	VISUAL EXAMINATION	PER P1	PER P1

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# PRODUCT SPECIFICATION

Test group CP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
CP 1	VIBRATION  PER IEC 60512-6-4, Test 6d (See Section 7.0)	$f = 10 \text{ Hz to } 500 \text{ Hz}$ , Amplitude: 0.35 mm Accel 50m/s <sup>2</sup> 10 sweeps / axis measurement points per section 7.0  (For arrangement, See IEC 60603-7, 7.3)	No discontinuities $\geq 10\mu\text{s}$ .
CP 2	CONTACT RESISTANCE  IEC 60512-2-1, Test 2a  No disturbance of the free connector to fixed connector electrical connections, between vibration test and contact resistance measurement	PER P3	20 m $\Omega$ maximum change from initial
CP 3	INSULATION RESISTANCE  IEC 60512-3-1, Test 3a, Method a.	PER P4	PER P4
CP 4	VISUAL EXAMINATION	PER P1	PER P1

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# PRODUCT SPECIFICATION

## Test group DP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
DP 1	ELECTRICAL LOAD AND TEMPERATURE PER IEC 60512-9-2, Test 9b	5 connectors 500 h 70° C Recovery period 2 h	0.8A 5 connectors, no current 5 connectors
DP 2	INSULATION RESISTANCE IEC 60512-3-1, Test 3a, Method a.	PER P4	PER P4
DP 3	VOLTAGE PROOF IEC 60512-4-1, Test 4a, Method a.	PER P5	PER P5
DP 4	VISUAL EXAMINATION	PER P1	PER P1
DP 5	CONTACT RESISTANCE IEC 60512-2-1, Test 2a	PER P3	20 mΩ maximum change from initial
DP 6	GAUGING PER IEC 60603-7, Annex C		All samples tested shall pass all gauges and forces
DP 7	GAUGING CONTINUITY PER IEC 60603-7, Annex A	All contacts/specimen	10 μs maximum

## Test group EP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
EP 1	N/A	N/A	N/A
EP 2			
EP 3			
EP 4			
EP 5			
EP 6			
EP 7	INPUT TO OUTPUT RESISTANCE PER IEC 60512-2, Test 2a	Mate Connectors	Signal contact resistance = 200 mΩ maximum.
EP 8	RESISTANCE UNBALANCE PER IEC 60512-2, Test 2a	Cable termination to cable termination.	Unbalance resistance = 50 mΩ maximum.

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# PRODUCT SPECIFICATION

## Test group FP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
FP 1	SURGE TEST PER IEC 60512, Test no. ITU_T K.20	Mated connectors, Table 2a /2b, Basic test level Tests 2.1.1a, 2.1.1b, 2.1.3, 2.2.1a and 2.3.1A	Test 2.1 & 2.2: Acceptance criteria A per ITU-T K.44, clause 9, Test 2.3: Acceptance criteria B PER ITU-T K.44, CLAUSE 9,
FP 2	INSULATION RESISTANCE IEC 60512-3-1, Test 3a, Method a.	100V $\pm$ 15V d.c. Method a Mated connectors	PER P4
FP 3	VISUAL EXAMINATION	PER P1	PER P1

## Test group AZ

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
AZ1	HIGH TEMPERATURE (DRY HEAT) PER IEC 60068-2-2, Test 9b	Mate connectors; expose to: 96 hours at 85 $\pm$ 2°C  Use Molex Plug 500602- 0819	
AZ 2	CONTACT RESISTANCE IEC 60512-2-1, Test 2a	PER P3	20 m $\Omega$ maximum change from initial for signal contacts. Input to output resistance 100 m $\Omega$ max for screen.

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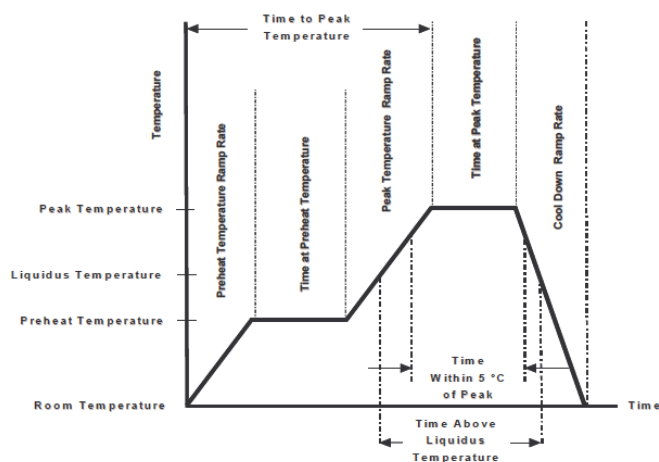


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## 6.0 SOLDERING CONDITIONS. **RECOMMENDED**

### REFLOW SOLDERING SIMULATION PEAK PROFILE REFLOW AT 260 °C

DESCRIPTION	REQUIREMENT
Solder Type	None
Solder Flux Type	None
Paste Flux Type	None
Average Ramp Rate	3 °C/second maximum
Preheat Temperature	150 °C minimum; 200 °C maximum
Preheat Time	60 to 180 seconds
Ramp to Peak	3 °C/second maximum
Time over Liquidus (217 °C)	60 to 150 seconds
Peak Temperature	260 °C +0/-5 °C
Time within 5 °C of peak	20 to 40 seconds
Ramp – Cool Down	6 °C/second maximum
Time 25 °C to Peak	8 minutes maximum



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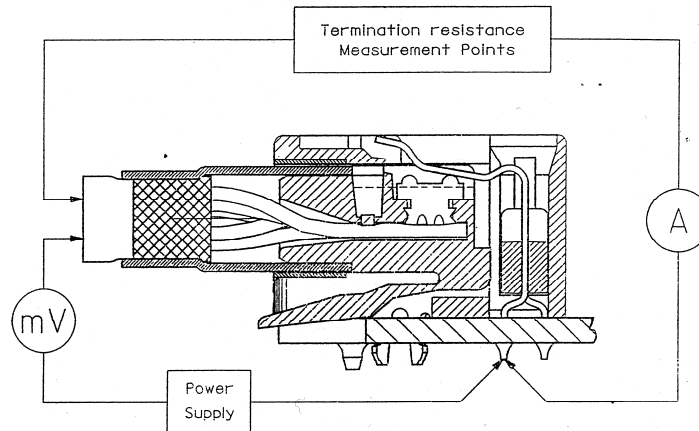
**A.Higgins**

APPROVED BY:

**E.Folan**

## 7.0 GAUGES AND FIXTURES

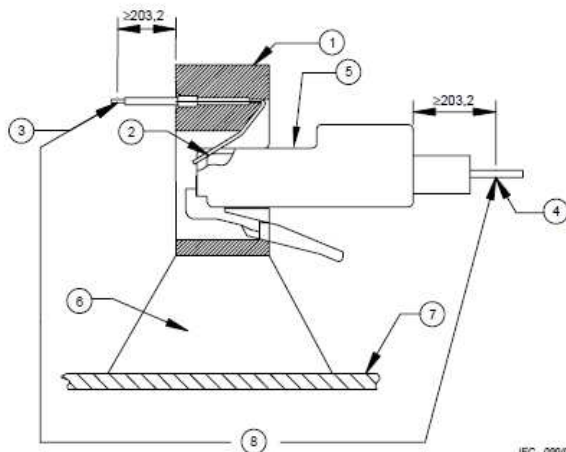
### CONTACT RESISTANCE



System resistance equals millivolt drop (mV) divided by test current (A)  
(Conductor resistance will be deducted from measurement).

### VIBRATION

Arrangement for vibration test (test phase CP1)



#### Key

- 1 Fixed connector vibration feature.
- 2 Contact point.
- 3 Point A: secure to the non-vibrating member.
- 4 Point C: secure to the non-vibrating member.
- 5 Free connector.
- 6 Fixed connector rigidly fixed to the mounting plate.
- 7 Mounting plate.
- 8 Contact resistance measurement point.

Arrangement for vibration test  
FROM IEC-60603-7

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## 8.0 PACKAGING

Parts shall be packaged to protect against damage during handling, transit and storage.  
(Refer to sales drawings)

## 9.0 QUALITY ASSURANCE PROVISIONS

The applicable Molex Inspection plan specifies the sampling acceptable quality level to be used.  
Dimensional and functional requirements shall be in accordance with applicable product drawings and this specification.

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